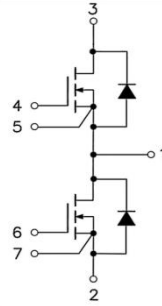


34mm Half Bridge SiC Module

Parameter	Value	Unit
V_{DS}	1200	V
I_D	160	A
$R_{DS(ON)}$	9	m Ω
Q_G	625	nC



Features:

- High Current Density
- Low Inductive Design
- Low Switching Losses
- High-frequency Operation
- Zero Turn-off Tail Current from MOSFET

Applications:

- High Power Converters
- Motor Drives
- UPS Systems

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source Voltage	1200	V
V_{GS}	Gate-source Voltage	-10/+22	V
I_D	Drain Current (continuous) ($T_C=25^\circ\text{C}$)	325	A
I_D	Drain Current (continuous) ($T_C=90^\circ\text{C}$)	160	A
I_{DM}	Drain Current (pulsed)	500	A
$T_{op}; T_{stg}$	Operating and Storage Temperature Range	-40 to +150	$^\circ\text{C}$
T_J	Junction Temperature	175	$^\circ\text{C}$
L_{Stray}	Stray Inductance	30	nH
V_{isol}	Isolation Test Voltage ($f=50\text{Hz}$; $t=1\text{min}$)	3.0	kV
M	Terminal Connection Torque (M5)	2.5-5.0	Nm
W	Weight	160	g

MOSFET Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
Static characteristics (at $T_C=25^\circ\text{C}$ unless otherwise specified)						
B_{VDS}	Drain-source Breakdown Voltage	1200	-	-	V	$V_{GS}=0\text{V}$
I_{DSS}	Zero Gate Voltage Drain Current	-	10	500	μA	$V_{DS}=1200\text{V}$; $V_{GS}=0\text{V}$
I_{GSS}	Gate-body Leakage Current	-	-	2.5	μA	$V_{GS}=-10/+20\text{V}$; $V_{DS}=0\text{V}$
$V_{GS(th)}$	Gate Threshold Voltage	2	-	4	V	$V_{DS}=V_{GS}$; $I_D=50\text{mA}$
$R_{DS(on)}$	Static Drain-source on Resistance	-	9	11	m Ω	$V_{GS}=18\text{V}$; $I_D=150\text{A}$; $T_J=25^\circ\text{C}$
		-	16.2	-	m Ω	$V_{GS}=18\text{V}$; $I_D=150\text{A}$; $T_J=175^\circ\text{C}$

$V_{GS(on)}$	Recommended Turn-on Voltage	-	18	-	V	Static
$V_{GS(off)}$	Recommended Turn-off Voltage	-	-5	-	V	
R_G	Gate Resistance	-	1.1	-	Ω	$V_{GS}=0V$; $f=1MHz$
Dynamic characteristics (at $T_C=25^\circ C$ unless otherwise specified)						
C_{iss}	Input Capacitance	-	12.8	-	nF	$V_{DS}=1000V$; $f=1MHz$; $V_{AC}=25mV$
C_{oss}	Output Capacitance	-	0.55	-		
C_{rss}	Reverse Transfer Capacitance	-	20	-	pF	
E_{on}	Turn-on Switching Energy	-	9.6	-	mJ	$V_{DD}=600V$; $V_{GS}=-5/+18V$; $I_D=200A$; $R_{G(ext)}=5\Omega$ Load=100 μH
E_{off}	Turn-off Switching Energy	-	1.0	-		
Q_{GS}	Gate-Source Charge	-	160	-	nC	$V_{DD}=800V$; $V_{GS}=-5/+18V$; $I_D=100A$
Q_{GD}	Gate-drain Charge	-	165	-		
Q_G	Total Gate Charge	-	625	-		
$t_{d(on)}$	Turn-on Delay Time	-	92	-	ns	$V_{DD}=600V$; $V_{GS}=-5/+18V$; $I_D=200A$; $R_{G(ext)}=5\Omega$ Load=100 μH
t_r	Rise Time	-	71	-		
$t_{d(off)}$	Turn-off Delay Time	-	227	-		
t_f	Fall Time	-	58	-		
$R_{th(j-c)}$	Thermal Resistance, Junction-to- heat sink	-	0.14	-	$^\circ C/W$	-

Body Diode Characteristics ($T_J=25^\circ C$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
V_{FSD}	Forward Voltage	-	-	6	V	$V_{GS}=0V$; $I_F=160A$
I_S	Continuous Diode Forward Current	-	150	-	A	$V_{GS}=0V$; $T_C=25^\circ C$
T_{RR}	Reverse Recovery Time	-	39	-	ns	$V_{GS}=-5/+18V$; $I_F=200A$; $V_R=600V$
Q_{RR}	Reverse Recovery Charge	-	3560	-	nC	
I_{RRM}	Peak Reverse Recovery Current	-	50	-	A	

Typical Characteristics

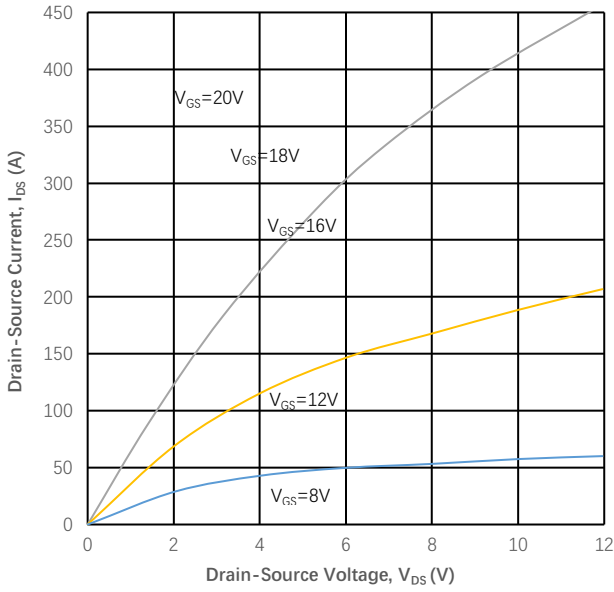


Figure 1
 Output Characteristics ($T_J=25\text{ }^\circ\text{C}$)

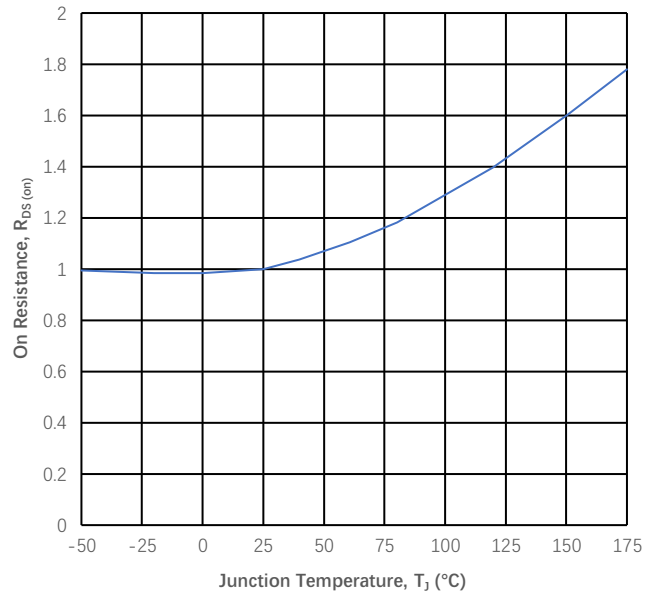


Figure 2
 Normalized On-Resistance vs. T_J

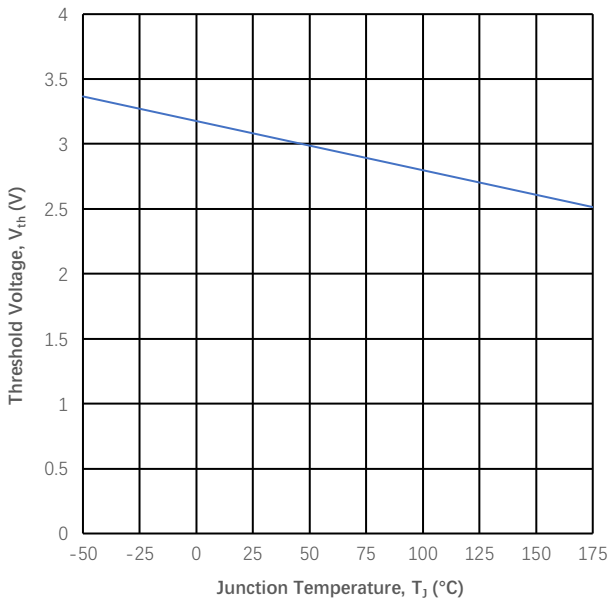


Figure 3
 Threshold Voltage vs. Temperature

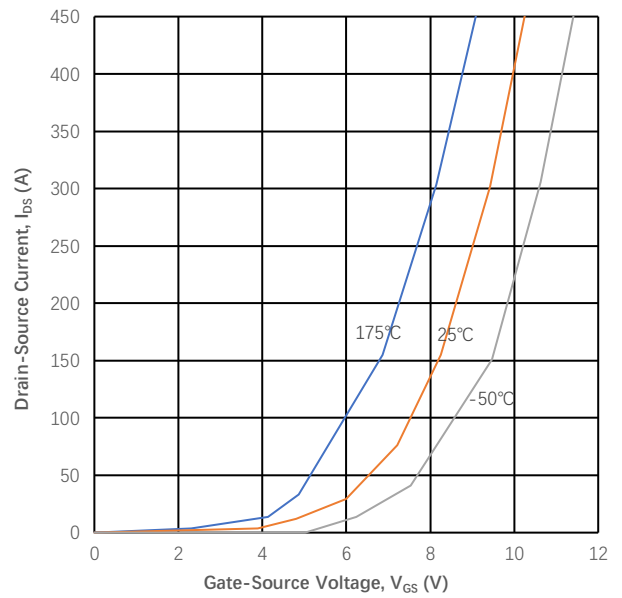


Figure 4
 Transfer Characteristic for Various T_J

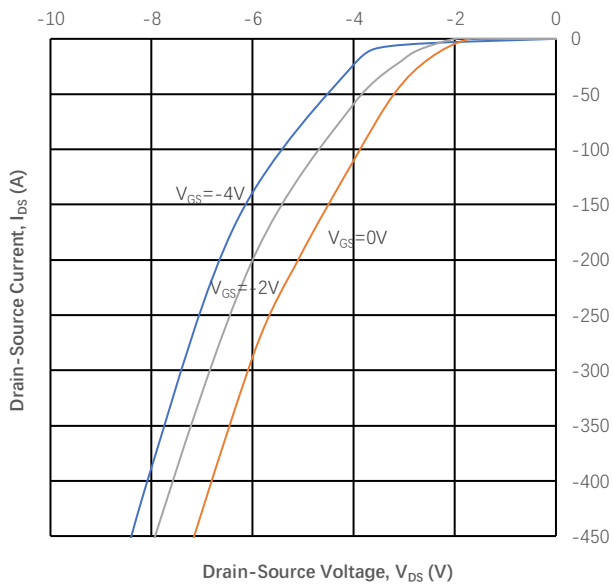


Figure 5
 Body Diode Characteristic at 25°C

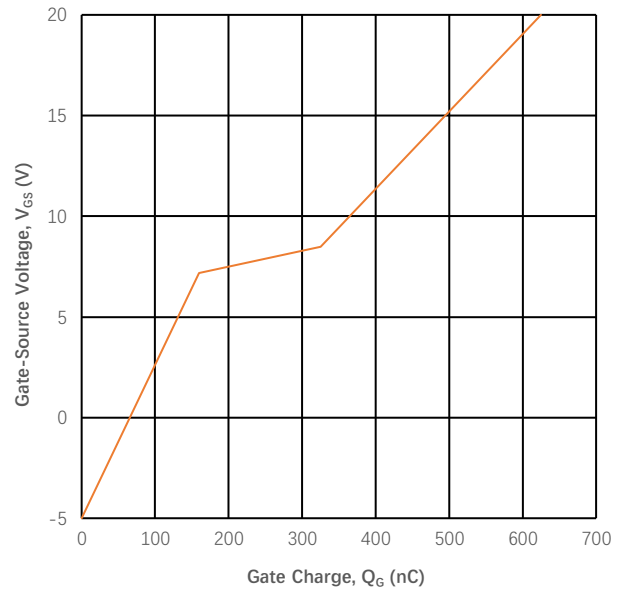


Figure 6
 Typical Gate Charge Characteristics

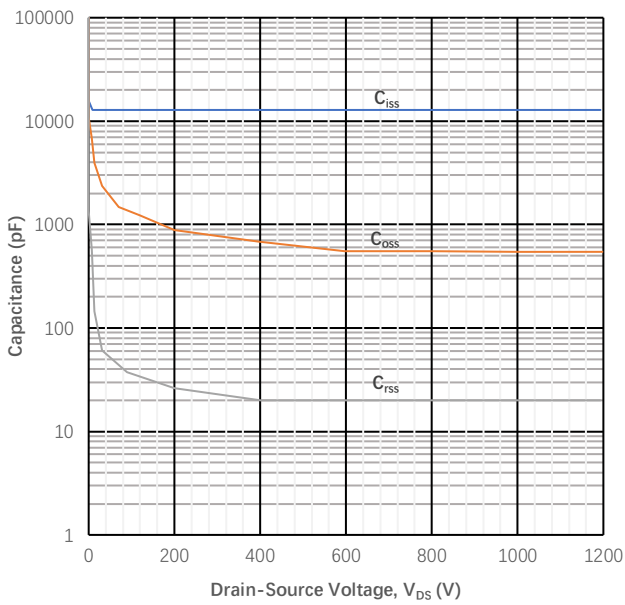


Figure 7
 Typical Capacitances vs. V_{DS}

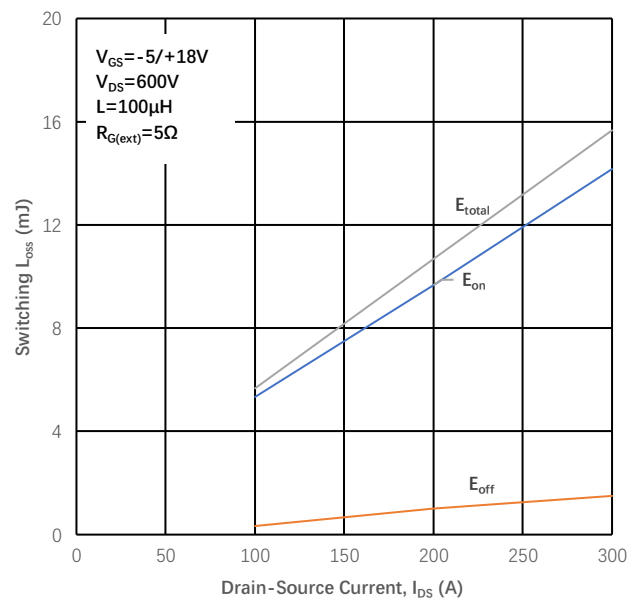


Figure 8
 Inductive Switching Energy vs. Drain Current

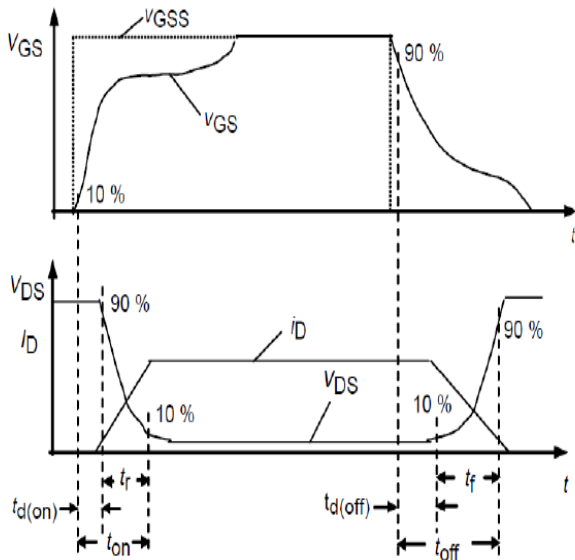


Figure 9
 Switching Time Description

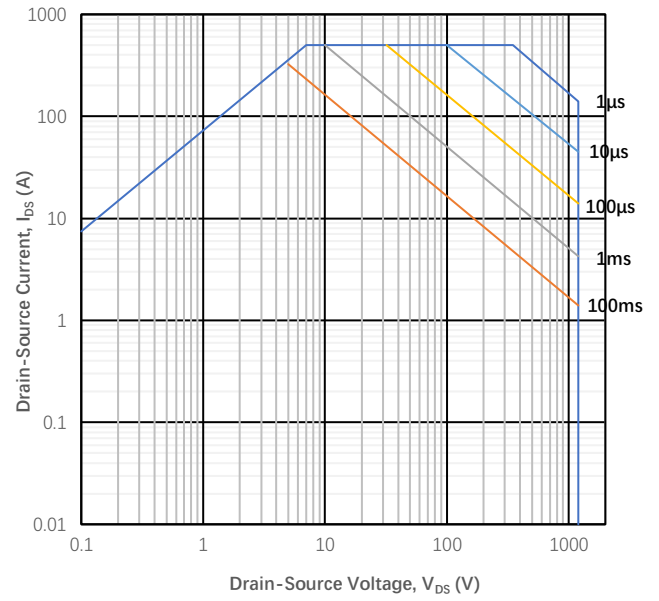
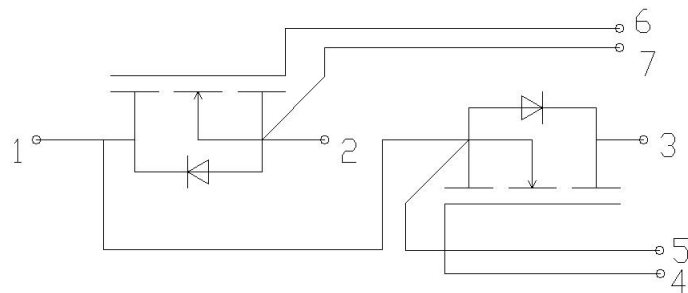
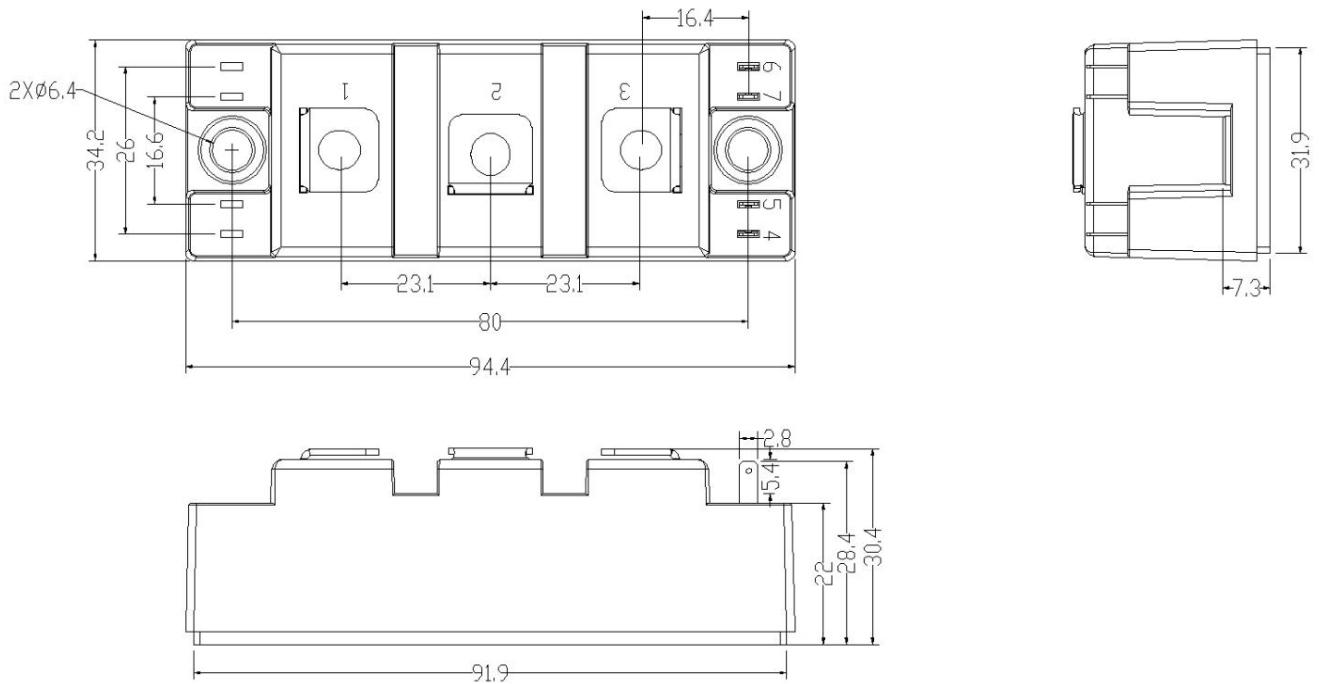


Figure 10
 Safe Operating Area

Circuit Diagram



Package Outlines(Unit: mm):



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